

BUZ80AFI

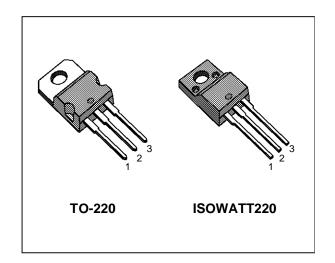
N - CHANNEL ENHANCEMENT MODE POWER MOS TRANSISTOR

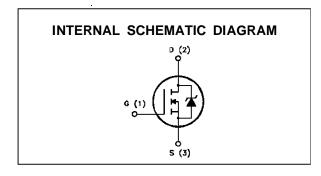
TYPE	V _{DSS}	R _{DS(on)}	ΙD
BUZ80A	800 V	< 3 Ω	3.8 A
BUZ80AFI	800 V	< 3 Ω	2.4 A

- TYPICAL $R_{DS(on)} = 2.5 \Omega$
- AVALANCHE RUGGED TECHNOLOGY
- 100% AVALANCHE TESTED
- REPETITIVE AVALANCHE DATA AT 100°C
- LOW INPUT CAPACITANCE
- LOW GATE CHARGE
- APPLICATION ORIENTED CHARACTERIZATION

APPLICATIONS

- HIGH CURRENT, HIGH SPEED SWITCHING
- SWITCH MODE POWER SUPPLIES (SMPS)
- CONSUMER AND INDUSTRIAL LIGHTING
- DC-AC INVERTERS FOR WELDING EQUIPMENT AND UNINTERRUPTIBLE POWER SUPPLY (UPS)





ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Va	lue	Unit
		BUZ80A	BUZ80AFI	
V _{DS}	Drain-source Voltage (V _{GS} = 0)	80	00	V
V_{DGR}	Drain- gate Voltage ($R_{GS} = 20 \text{ k}\Omega$)	80	00	V
V _G s	Gate-source Voltage	±	20	V
I _D	Drain Current (continuous) at T _c = 25 °C	3.8	2.4	А
I _D	Drain Current (continuous) at T _c = 100 °C	2.3	1.4	А
I _{DM} (•)	Drain Current (pulsed)	15	15	Α
Ptot	Total Dissipation at T _c = 25 °C	100	40	W
	Derating Factor	0.8	0.32	W/°C
V _{ISO}	Insulation Withstand Voltage (DC)	_	2000	V
T _{stg}	Storage Temperature	-65 to 150		°C
Tj	Max. Operating Junction Temperature	15	50	°C

(•) Pulse width limited by safe operating area

April 1993 1/10

THERMAL DATA

			TO-220	ISOWATT220	
R _{thj-case}	Thermal Resistance Junction-case	Max	1.25	3.12	°C/W
,	Thermal Resistance Junction-ambient Thermal Resistance Case-sink Maximum Lead Temperature For Soldering Pu	Max Typ irpose	62 0 30	.5	°C/W °C/W °C

AVALANCHE CHARACTERISTICS

Symbol	Parameter	Max Value	Unit
I _{AR}	Avalanche Current, Repetitive or Not-Repetitive (pulse width limited by T_j max, $\delta < 1\%$)	3.8	А
Eas	Single Pulse Avalanche Energy (starting $T_j = 25$ °C, $I_D = I_{AR}$, $V_{DD} = 50$ V)	200	mJ
E _{AR}	Repetitive Avalanche Energy (pulse width limited by T_j max, δ < 1%)	8	mJ
I _{AR}	Avalanche Current, Repetitive or Not-Repetitive $(T_c = 100 ^{\circ}\text{C}, \text{ pulse width limited by } T_j \text{max}, \delta < 1\%)$	2.2	А

ELECTRICAL CHARACTERISTICS ($T_{case} = 25$ ^{o}C unless otherwise specified) OFF

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source Breakdown Voltage	$I_D = 250 \mu\text{A}$ $V_{GS} = 0$	800			\ \
I _{DSS}	Zero Gate Voltage Drain Current (V _{GS} = 0)	$V_{DS} = Max Rating$ $V_{DS} = Max Rating x 0.8 T_c = 125 °C$			250 1000	μA μA
I _{GSS}	Gate-body Leakage Current (V _{DS} = 0)	$V_{GS} = \pm 20 \text{ V}$			± 100	nA

ON (*)

Symbol	Parameter	Test Conditions		Тур.	Max.	Unit
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}$ $I_D = 1 \text{ mA}$	2	3	4	V
R _{DS(on)}	Static Drain-source On Resistance	$V_{GS} = 10 \text{ V}$ $I_D = 1.7 \text{ A}$ $V_{GS} = 10 \text{ V}$ $I_D = 1.7 \text{ A}$ $T_c = 100^{\circ}\text{C}$		2.5	3 6	Ω Ω
I _{D(on)}	On State Drain Current	$V_{DS} > I_{D(on)} \times R_{DS(on)max}$ $V_{GS} = 10 \text{ V}$	3.8			Α

DYNAMIC

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
gfs (*)	Forward Transconductance	$V_{DS} > I_{D(on)} \times R_{DS(on)max}$ $I_{D} = 1.7 \text{ A}$	1			S
C _{iss} C _{oss} C _{rss}	Input Capacitance Output Capacitance Reverse Transfer Capacitance	$V_{DS} = 25 \text{ V}$ f = 1 MHz $V_{GS} = 0$			1100 150 55	pF pF pF



ELECTRICAL CHARACTERISTICS (continued)

SWITCHING ON

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
t _{d(on)} t _r	Turn-on Time Rise Time	$V_{DD} = 30 \text{ V}$ $I_D = 2.3 \text{ A}$ $R_G = 50 \Omega$ $V_{GS} = 10 \text{ V}$ (see test circuit, figure 3)		65 150	90 200	ns ns
(di/dt) _{on}	Turn-on Current Slope	$V_{DD} = 600 \text{ V}$ $I_D = 3.8 \text{ A}$ $R_G = 50 \Omega$ $V_{GS} = 10 \text{ V}$ (see test circuit, figure 5)		80	110	A/μs
$egin{array}{c} Q_g \ Q_{gs} \ Q_{gd} \end{array}$	Total Gate Charge Gate-Source Charge Gate-Drain Charge	$V_{DD} = 400 \text{ V}$ $I_{D} = 5 \text{ A}$ $V_{GS} = 10 \text{ V}$		55 8 26	70	nC nC nC

SWITCHING OFF

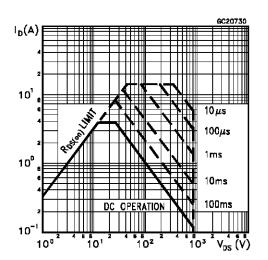
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
$t_{r(Voff)}$ t_{f}	, ,	$V_{DD} = 600 \text{ V}$ $I_D = 3.8 \text{ A}$ $R_G = 50 \Omega$ $V_{GS} = 10 \text{ V}$		110 140	145 190	ns ns
		(see test circuit, figure 5)		150	200	ns

SOURCE DRAIN DIODE

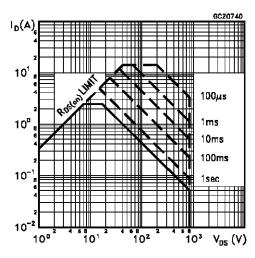
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
I _{SD} I _{SDM} (•)	Source-drain Current Source-drain Current (pulsed)				3.8 15	A
V _{SD} (*)	Forward On Voltage	I _{SD} = 7.6 A V _{GS} = 0			2	V
t _{rr}	Reverse Recovery Time	$I_{SD} = 3.8 \text{ A}$ di/dt = 100 A/ μ s V _R = 100 V $T_j = 150 ^{\circ}\text{C}$		500		ns
Q_{rr}	Reverse Recovery Charge	(see test circuit, figure 5)		4.3		μC
I _{RRM}	Reverse Recovery Current			17		А

^(*) Pulsed: Pulse duration = 300 μs, duty cycle 1.5 %

Safe Operating Areas For TO-220 Package

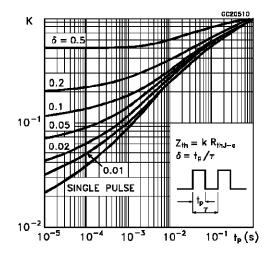


Safe Operating Areas For ISOWATT220 Package

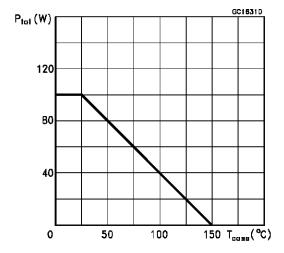


^(•) Pulse width limited by safe operating area

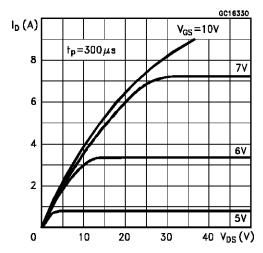
Thermal Impedeance For TO-220 Package



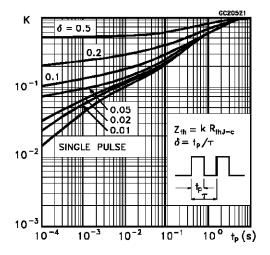
Derating Curve For TO-220 Package



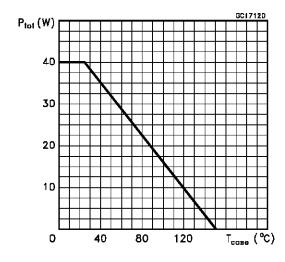
Output Characteristics



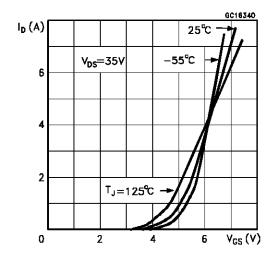
Thermal Impedance For ISOWATT220 Package



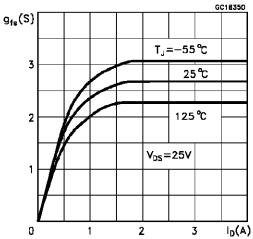
Derating Curve For ISOWATT220 Package



Transfer Characteristics

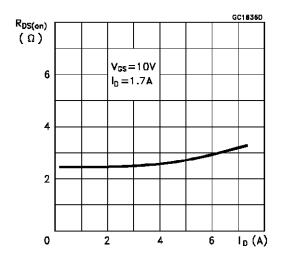


Transconductance

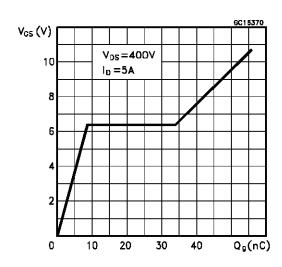


Static Drain-source On Resistance

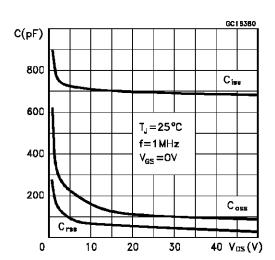
Capacitance Variations



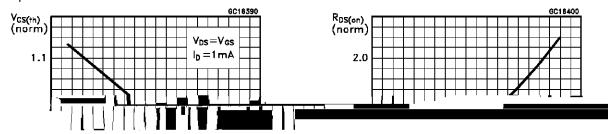
Gate Charge vs Gate-source Voltage



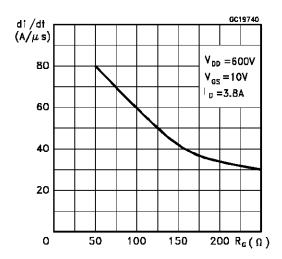
Normalized Gate Threshold Voltage vs Temperature



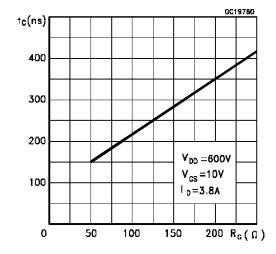
Normalized On Resistance vs Temperature



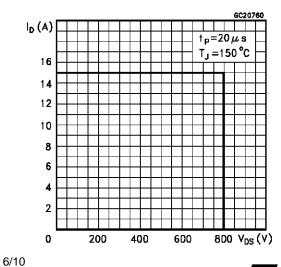
Turn-on Current Slope



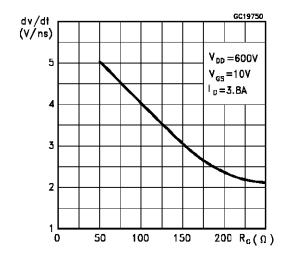
Cross-over Time



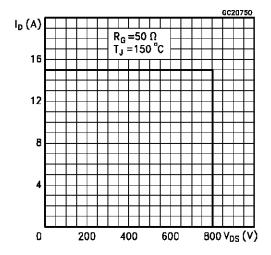
Accidental Overload Area



Turn-off Drain-source Voltage Slope



Switching Safe Operating Area



Source-drain Diode Forward Characteristics

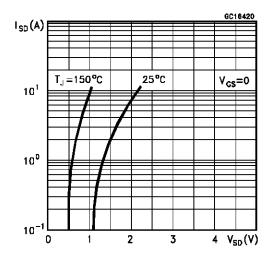


Fig. 1: Unclamped Inductive Load Test Circuits

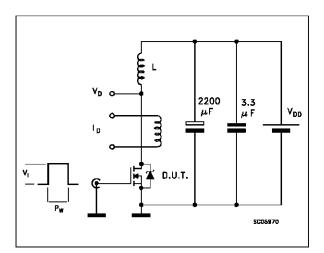


Fig. 3: Switching Times Test Circuits For Resistive Load

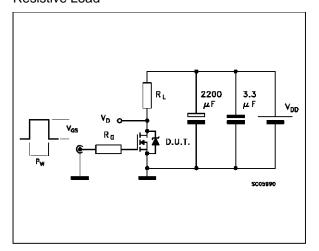


Fig. 5: Test Circuit For Inductive Load Switching And Diode Reverse Recovery Time

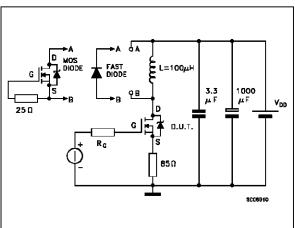


Fig. 2: Unclamped Inductive Waveforms

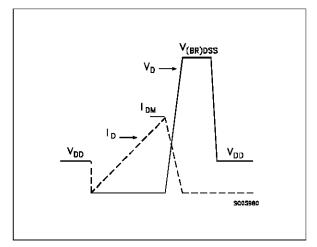
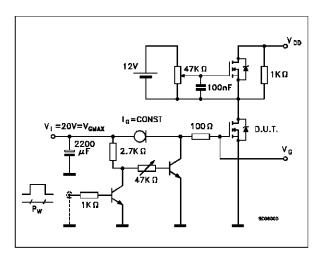
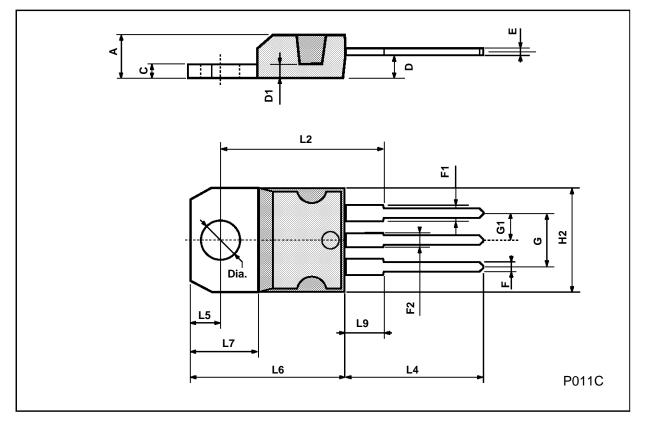


Fig. 4: Gate Charge Test Circuit



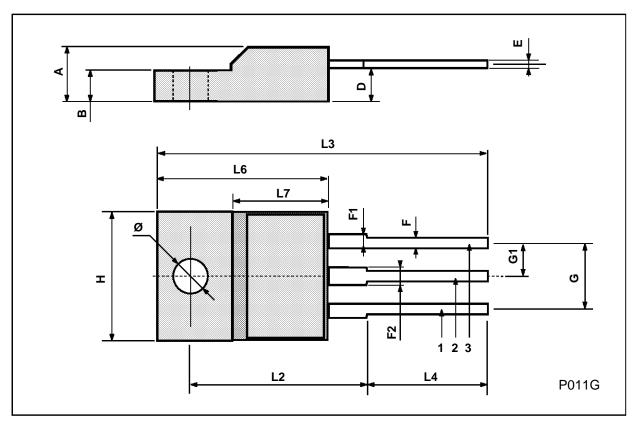
TO-220 MECHANICAL DATA

DIM.		mm			inch	
DIN.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
Α	4.40		4.60	0.173		0.181
С	1.23		1.32	0.048		0.051
D	2.40		2.72	0.094		0.107
D1		1.27			0.050	
E	0.49		0.70	0.019		0.027
F	0.61		0.88	0.024		0.034
F1	1.14		1.70	0.044		0.067
F2	1.14		1.70	0.044		0.067
G	4.95		5.15	0.194		0.203
G1	2.4		2.7	0.094		0.106
H2	10.0		10.40	0.393		0.409
L2		16.4			0.645	
L4	13.0		14.0	0.511		0.551
L5	2.65		2.95	0.104		0.116
L6	15.25		15.75	0.600		0.620
L7	6.2		6.6	0.244		0.260
L9	3.5		3.93	0.137		0.154
DIA.	3.75		3.85	0.147		0.151



ISOWATT220 MECHANICAL DATA

DIM.		mm			inch	
DIIVI.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
А	4.4		4.6	0.173		0.181
В	2.5		2.7	0.098		0.106
D	2.5		2.75	0.098		0.108
E	0.4		0.7	0.015		0.027
F	0.75		1	0.030		0.039
F1	1.15		1.7	0.045		0.067
F2	1.15		1.7	0.045		0.067
G	4.95		5.2	0.195		0.204
G1	2.4		2.7	0.094		0.106
Н	10		10.4	0.393		0.409
L2		16			0.630	
L3	28.6		30.6	1.126		1.204
L4	9.8		10.6	0.385		0.417
L6	15.9	_	16.4	0.626		0.645
L7	9		9.3	0.354		0.366
Ø	3		3.2	0.118		0.126



BUZ80A/BUZ80AFI

Information furnished is believed to be accurate and reliable. However, SGS-THOMSON Microelectronics assumes no responsability for the consequences of use of such information nor for any infringement of patents or other rights of third parties which may results from its use. No license is granted by implication or otherwise under any patent or patent rights of SGS-THOMSON Microelectronics. Specifications mentioned in this publication are subject to change without notice. This publication supersedes and replaces all information previously supplied. SGS-THOMSON Microelectronics products are not authorized for use as critical components in life support devices or systems without express written approval of SGS-THOMSON Microelectonics.

© 1994 SGS-THOMSON Microelectronics - All Rights Reserved

SGS-THOMSON Microelectronics GROUP OF COMPANIES

Australia - Brazil - France - Germany - Hong Kong - Italy - Japan - Korea - Malaysia - Malta - Morocco - The Netherlands - Singapore - Spain - Sweden - Switzerland - Taiwan - Thailand - United Kingdom - U.S.A

